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Application/Control No.	Applicant(s)/Patent under Reexamination		
10/762,571	ABDEL-HAFEZ ET AL.		
Examiner	Art Unit		
R. Stephen Dildine	2133		

SEARCHED				
Class	Subclass	Date	Examiner	
714	727 & 729	11/15/2005	RSD	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
714/726 (U.S. documents, see Search History printout)	11/14/2005	RSD
G01R 31/3177, G01R 31/3181 (foreign documents, see Search History printout)	11/14/2005	RSD
G01R 31/3188 (text search of foreign documents, see Search History printout)	11/14/2005	RSD
US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB (see Search History printout)	11/15/2005	RSD
INSPEC, IEEE Xplore, Google	11/15/2005	RSD
Inventors' name search	11/15/2005	RSD